

N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)		
40	2.7 at V _{GS} = 10 V	100	120 nC		
	3.2 at V _{GS} = 4.5 V	70	120110		

FEATURES

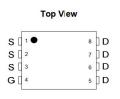
- DT-Trench Power MOSFET
- 100 % R_g and UIS tested

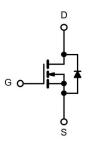
COMPLIANT

APPLICATIONS

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		100 ^a		
Continuous Drain Current (T _{.I} = 175 °C)	T _C = 70 °C	l _D	78		
Continuous Diam Current (1) = 173 C)	T _A = 25 °C		25 ^{b, c}	A	
	T _A = 70 °C		20 ^{b, c}		
Pulsed Drain Current		I _{DM}	300		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	22		
Single Pulse Avalanche Energy	L = 0.1 IIII1	E _{AS}	49.2	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	o _l	100 ^a	Α	
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	3.06 ^{b, c}		
	T _C = 25 °C		250 ^a		
Maximum Power Dissipation	T _C = 70 °C	P _D	175	w	
Maximum Power Dissipation	T _A = 25 °C	טיי	3.45 ^{b, c}] vv	
	T _A = 70 °C		2.41 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	35	43.5	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.4	0.6	- C/VV	

- Notes:
 a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
 c. t = 10 s.
 d. Maximum under steady state conditions is 90 °C/W.

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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 - 200 μΑ		- 5.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oata Valta na Draia Oana t	I _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α	
	В	V _{GS} = 10 V, I _D = 30 A		2.7	3.5	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$		3.2	4.0		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A		110		S	
Dynamic ^b							
Input Capacitance	C _{iss}			6480		pF	
Output Capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		469			
Reverse Transfer Capacitance	C _{rss}			445			
Total Gate Charge	Qg			120		nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 30 \text{ A}$		12.5			
Gate-Drain Charge	Q_{gd}			20			
Gate Resistance	R_g	f = 1 MHz		1.1		Ω	
Turn-On Delay Time	t _{d(on)}			18			
Rise Time	t _r	V_{DD} = 20 V, R_{L} = 0.555 Ω		12			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 30 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		70			
Fall Time	t _f			10			
Turn-On Delay Time	t _{d(on)}			58		ns	
Rise Time	t _r	V_{DD} = 20 V, R_L = 0.625 Ω		185		-	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 30A,V_{GEN}$ = 4.5 V, R_g = 1 Ω		59			
Fall Time	t _f			14			
Drain-Source Body Diode Characteristics	5						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			100	_	
Pulse Diode Forward Current ^a	I _{SM}				300	A	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			55	78	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 30 A di/dt = 100 A/vo T = 25 °C		123.2		nC	
Reverse Recovery Fall Time	t _a	$I_F = 30 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		30			
Reverse Recovery Rise Time	t _b			29		ns	

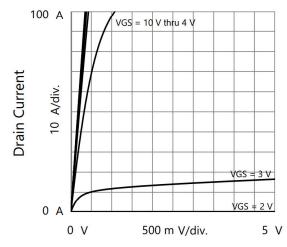
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

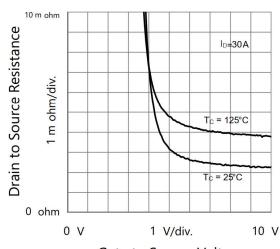
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



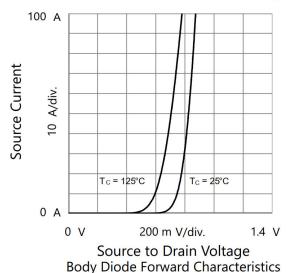
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

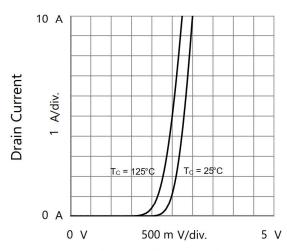


Drain to Source Voltage Output Characteristics

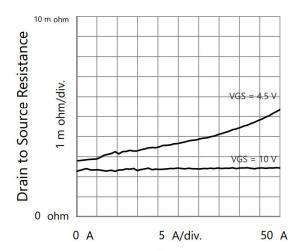


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

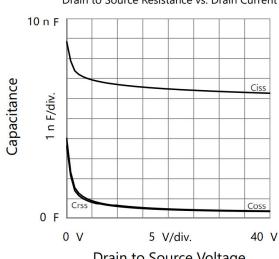




Gate to Source Voltage Transfer Characteristics



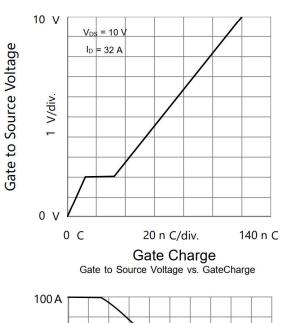
Drain Current
Drain to Source Resistance vs. Drain Current

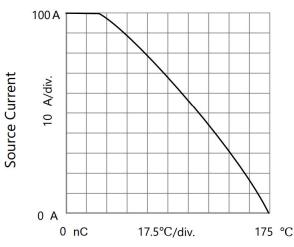


Drain to Source Voltage Capacitances



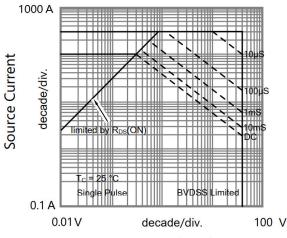
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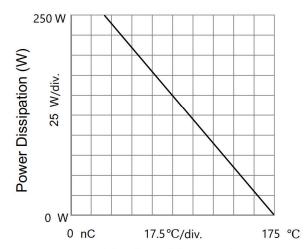


T_C - Case Temperature

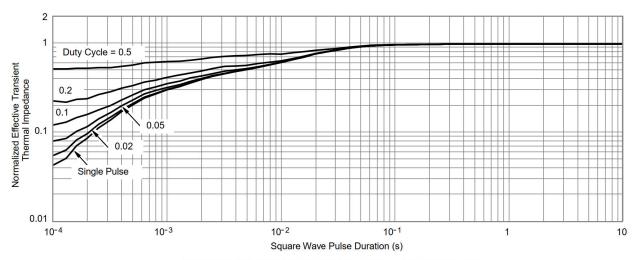
Current Derating



Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



T_C - Case Temperature Power Derating



Normalized Thermal Transient Impedance, Junction-to-Case





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